

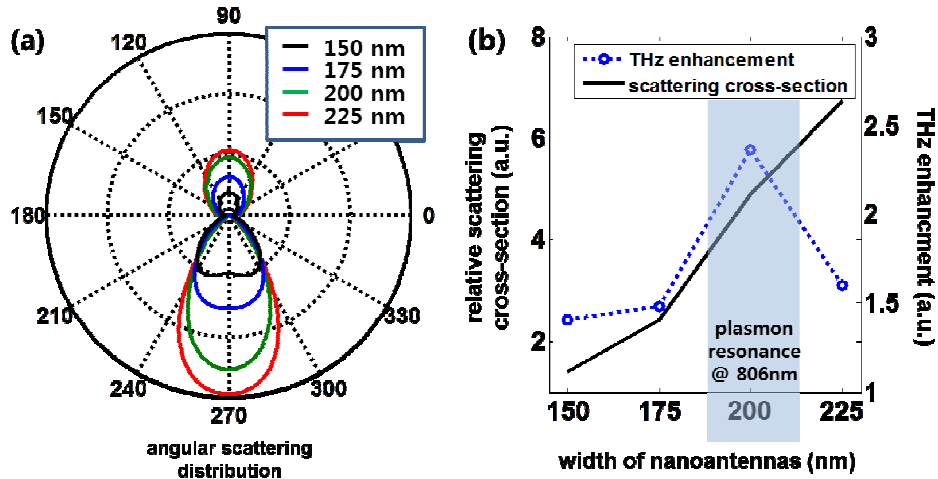
## Supporting Information

### Enhancement of Terahertz Pulse Emission by Optical Nanoantenna

*Sang-Gil Park<sup>1,3</sup>, Kyong Hwan Jin<sup>1</sup>, Minwoo Yi<sup>2,3</sup>, Jong Chul Ye<sup>1</sup>, Jaewook Ahn<sup>2,3</sup> and Ki-Hun Jeong<sup>1,3\*</sup>*

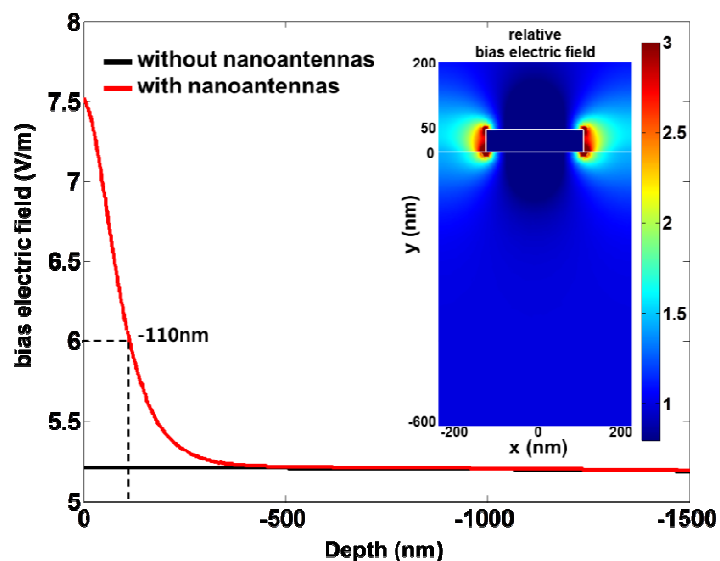
<sup>1</sup>Department of Bio and Brain Engineering, <sup>2</sup>Department of Physics, and <sup>3</sup>KAIST Institute for Optical Science and Technology, Korea Advanced Institute of Science and Technology (KAIST), 291 Daehak-ro, Yuseong-gu, Daejeon 305-701, Republic of Korea

#### Asymmetric scattering depending on the nanoantenna widths



**Figure S1.** (a) Scattering distribution of optical nanoantennas on the SI-GaAs with different widths and (b) relative scattering cross-section with THz enhancement. The scattering cross-section increases with the nanoantenna width.

**Bias electric field distribution.** The bias electric field distribution was calculated by using the finite element analysis software, COMSOL Multiphysics (COMSOL 3.5, COMSOL Corp., Burlington, MA).



**Figure S2.** The bias electric field in the middle of the photoconductive region for with and without 200 nm wide nanoantennas as a function of a substrate depth (y-axis) and (subfigure) the distribution of relative bias electric field in the cross-section of optical nanoantennas.

**Calculation of photocurrent.** The amplitude of electric field of THz wave emitted from PCAs is related with the surface current. The THz wave generated from the PCA is proportional to the first-order time derivative of the surface current,

$$\mathbf{E}(t) \propto \frac{\partial \mathbf{J}_s(t)}{\partial t}$$

$$\mathbf{J}_s(t) = \int_0^\delta \mathbf{J}(z,t) dz$$

where  $\mathbf{J}_s(t)$  is the surface current,  $\mathbf{J}(z,t)$  is the current density and  $\delta$  is the distance into the photoconductor.

In general, current density is determined by multiply of the number of carrier and the bias electric field, as shown the follow equation,

$$\mathbf{J}(r,t) = q n(r,t) v_d(r,t) = q n(r,t) * \mu E_b(r,t)$$

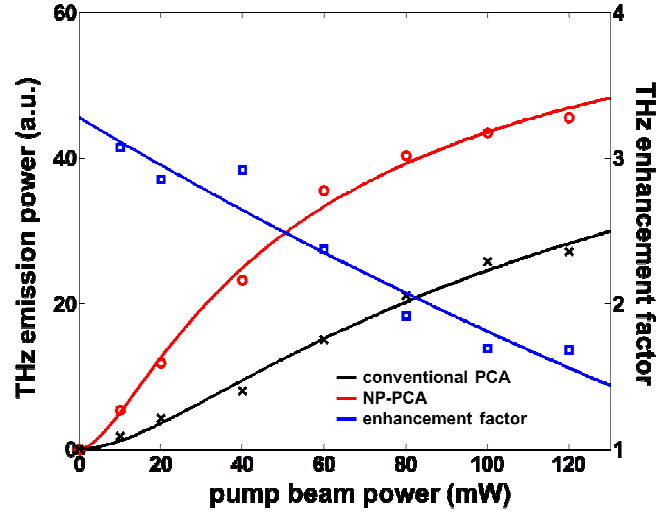
where  $n(r,t)$  is the carrier density,  $v_d(r,t)$  is draft velocity,  $\mu$  is the electron mobility and

$E_b(r,t)$  is the bias electric field. And the carrier density can be calculated from the energy density

absorbed in a photoconductive substrate,  $\frac{\text{imag}(\epsilon)|E|^2}{2}$ . Therefore increase of photocurrent can be

obtained from the optical electric field and the bias electric field. Calculated based on above equation, photocurrent is increased by 2 times in the photoconductive layer, which corresponding to 4 times THz enhancement factor. The thickness of photoconductive layer is assumed to be 110 nm where the bias electric field has fallen to 1/e (about 0.37) of its peak value.

**Saturation of THz emission power.** The experiment of the saturation of THz emission was carried out with increasing pump beam power.



**Figure S3.** THz emission power from the NP-PCA integrating 200 nm wide nanoantennas and the conventional PCA, and THz enhancement factor depending on optical pump beam power. The THz emission from NP-PCA is saturated around 80 mW.